

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FINSTER ET AL.	
		Examiner Annan Q. Shang	Art Unit 2623	Page 1 of 1

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*	C	US-6,715,129	03-2004	Hind et al.	715/513
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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